Search Notes			

Application/Control No.	Applicant(s)/Patent un Reexamination	Applicant(s)/Patent under Reexamination	
10/539,373	FUKUMOTO ET AL.		
Examiner	Art Unit		
A. J. HEINZ	2627		

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Subclass	Date	Examiner
324.2	East 1/18/08	sq
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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